

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/779,897	YAZAWA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Deborah Yee	1742

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
140	651 610	9/12/2005	DY
	537		